Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/626,140	FUKAGAWA ET AL.	
Examiner	Art Unit	
Alex Liew	2624	

	SEARCHED				
Class	Subclass	Date	Examiner		
			i		
	!				

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
l				

SEARCH NO (INCLUDING SEARCH	STRATEGY)	<u> </u>
	DATE	EXMR
382/141-152 (limited to text search)	10/12/2006	AL
382/141-152 (limited to text search) UPDATED	1/23/2007	AL